

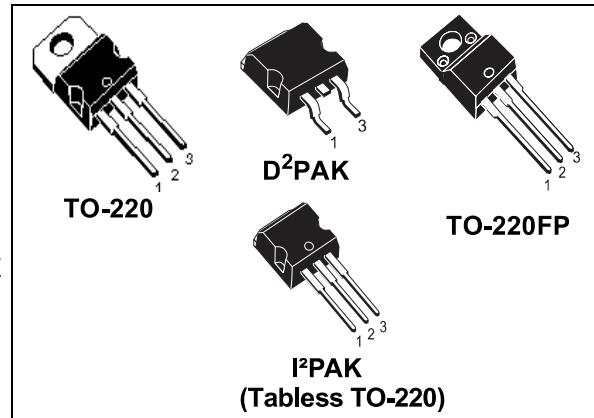


# STP20NM50 - STP20NM50FP STB20NM50 - STB20NM50-1

N-CHANNEL 500V - 0.20Ω - 20A TO-220/FP/D<sup>2</sup>PAK/I<sup>2</sup>PAK  
MDmesh™ Power MOSFET

TYPE	V <sub>DSS</sub>	R <sub>D(on)</sub>	I <sub>D</sub>
STP20NM50/FP	500V	<0.25Ω	20 A
STB20NM50	500V	<0.25Ω	20 A
STB20NM50-1	500V	<0.25Ω	20 A

- TYPICAL R<sub>D(on)</sub> = 0.20Ω
- HIGH dv/dt AND AVALANCHE CAPABILITIES
- 100% AVALANCHE TESTED
- LOW INPUT CAPACITANCE AND GATE CHARGE
- LOW GATE INPUT RESISTANCE
- TIGHT PROCESS CONTROL AND HIGH MANUFACTURING YIELDS



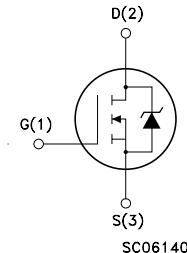
## DESCRIPTION

The MDmesh™ is a new revolutionary MOSFET technology that associates the Multiple Drain process with the Company's PowerMESH™ horizontal layout. The resulting product has an outstanding low on-resistance, impressively high dv/dt and excellent avalanche characteristics. The adoption of the Company's proprietary strip technique yields overall dynamic performance that is significantly better than that of similar competition's products.

## APPLICATIONS

The MDmesh™ family is very suitable for increasing power density of high voltage converters allowing system miniaturization and higher efficiencies.

## INTERNAL SCHEMATIC DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value		Unit
		STP(B)20NM50(-1)	STP20NM50FP	
V <sub>DS</sub>	Drain-source Voltage (V <sub>GS</sub> = 0)	500		V
V <sub>DGR</sub>	Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)	500		V
V <sub>GS</sub>	Gate- source Voltage	±30		V
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 25°C	20	20(*)	A
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 100°C	12.6	12.6(*)	A
I <sub>DM</sub> (●)	Drain Current (pulsed)	80	80(*)	A
P <sub>TOT</sub>	Total Dissipation at T <sub>C</sub> = 25°C	192	45	W
	Derating Factor	1.2	0.36	W/°C
dv/dt(1)	Peak Diode Recovery voltage slope	15		V/ns
V <sub>ISO</sub>	Insulation Winthstand Voltage (DC)	--	2000	V
T <sub>stg</sub>	Storage Temperature	-65 to 150		°C
T <sub>j</sub>	Max. Operating Junction Temperature	150		°C

(•)Pulse width limited by safe operating area  
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(1)I<sub>SD</sub> ≤ 20A, di/dt ≤ 400A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>j</sub> ≤ T<sub>JMAX</sub>.

(\*)Limited only by maximum temperature allowed

1/12